

EN: This Datasheet is presented by the manufacturer.

Please visit our website for pricing and availability at www.hestore.hu.

Preferred Device

# **Silicon Power Transistors**

The MJL21193 and MJL21194 utilize Perforated Emitter technology and are specifically designed for high power audio output, disk head positioners and linear applications.

#### **Features**

- Total Harmonic Distortion Characterized
- High DC Current Gain -

 $h_{FE} = 25 \text{ Min } @ I_{C}$ = 8 Adc

- Excellent Gain Linearity
- High SOA: 2.25 A, 80 V, 1 Second
- Pb-Free Packages are Available\*

#### **MAXIMUM RATINGS**

| Rating  | Symbol                            | Value          | Unit      |
|---|-----------------------------------|----------------|-----------|
| Collector-Emitter Voltage   | V <sub>CEO</sub>                  | 250            | Vdc       |
| Collector-Base Voltage  | V <sub>CBO</sub>                  | 400            | Vdc       |
| Emitter-Base Voltage  | V <sub>EBO</sub>                  | 5              | Vdc       |
| Collector-Emitter Voltage - 1.5 V                                 | V <sub>CEX</sub>                  | 400            | Vdc       |
| Collector Current - Continuous<br>Peak (Note 1)                   | I <sub>C</sub>                    | 16<br>30       | Adc       |
| Base Current - Continuous   | I <sub>B</sub>                    | 5              | Adc       |
| Total Power Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C | P <sub>D</sub>                    | 200<br>1.43    | W<br>W/°C |
| Operating and Storage Junction<br>Temperature Range               | T <sub>J</sub> , T <sub>stg</sub> | -65 to<br>+150 | °C        |

#### THERMAL CHARACTERISTICS

| Characteristic                       | Symbol          | Max | Unit |
|--------------------------------------|-----------------|-----|------|
| Thermal Resistance, Junction-to-Case | $R_{\theta JC}$ | 0.7 | °C/W |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Pulse Test: Pulse Width = 300 μs, Duty Cycle ≤2%

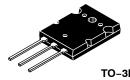


# ON Semiconductor®

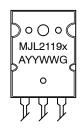
http://onsemi.com

# 16 AMPERE COMPLEMENTARY SILICON POWER TRANSISTORS 250 VOLTS, 200 WATTS

# MARKING DIAGRAM



TO-3PBL (TO-264) CASE 340G



= 3 or 4

A = Assembly Location

YY = Year WW = Work Week G = Pb-Free Package

# **ORDERING INFORMATION**

| Device    | Package             | Shipping <sup>†</sup> |
|-----------|---------------------|-----------------------|
| MJL21193  | TO-264              | 25 Units / Rail       |
| MJL21193G | TO-264<br>(Pb-Free) | 25 Units / Rail       |
| MJL21194  | TO-264              | 25 Units / Rail       |
| MJL21194G | TO-264<br>(Pb-Free) | 25 Units / Rail       |

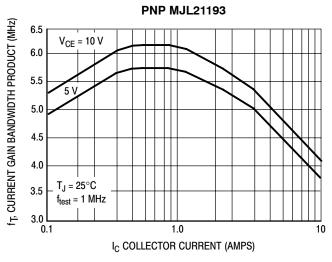
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

**Preferred** devices are recommended choices for future use and best overall value.

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

## **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

| Characteristic  | Symbol                | Min         | Тур    | Max      | Unit |
|---|-----------------------|-------------|--------|----------|------|
| OFF CHARACTERISTICS   | 1                     |             | 1      |          | 1    |
| Collector–Emitter Sustaining Voltage ( $I_C = 100$ mAdc, $I_B = 0$ )  | V <sub>CEO(sus)</sub> | 250         | -      | -        | Vdc  |
| Collector Cutoff Current (V <sub>CE</sub> = 200 Vdc, I <sub>B</sub> = 0)  | I <sub>CEO</sub>      | -           | -      | 100      | μAdc |
| Emitter Cutoff Current (V <sub>CE</sub> = 5 Vdc, I <sub>C</sub> = 0)  | I <sub>EBO</sub>      | _           | -      | 100      | μAdc |
| Collector Cutoff Current<br>(V <sub>CE</sub> = 250 Vdc, V <sub>BE(off)</sub> = 1.5 Vdc)   | I <sub>CEX</sub>      | -           | -      | 100      | μAdc |
| SECOND BREAKDOWN  |                       |             |        |          |      |
| Second Breakdown Collector Current with Base Forward Biased (V <sub>CE</sub> = 50 Vdc, t = 1 s (non-repetitive) (V <sub>CE</sub> = 80 Vdc, t = 1 s (non-repetitive) | I <sub>S/b</sub>      | 4.0<br>2.25 | -<br>- | _<br>_   | Adc  |
| ON CHARACTERISTICS  |                       |             | l      |          | l    |
| DC Current Gain ( $I_C = 8$ Adc, $V_{CE} = 5$ Vdc) ( $I_C = 16$ Adc, $I_B = 5$ Adc)   | h <sub>FE</sub>       | 25<br>8     | -<br>- | 75<br>-  |      |
| Base-Emitter On Voltage<br>(I <sub>C</sub> = 8 Adc, V <sub>CE</sub> = 5 Vdc)  | V <sub>BE(on)</sub>   | _           | -      | 2.2      | Vdc  |
| Collector–Emitter Saturation Voltage ( $I_C$ = 8 Adc, $I_B$ = 0.8 Adc) ( $I_C$ = 16 Adc, $I_B$ = 3.2 Adc)   | V <sub>CE(sat)</sub>  | -<br>-      | -<br>- | 1.4<br>4 | Vdc  |
| DYNAMIC CHARACTERISTICS   |                       |             |        |          |      |
| Total Harmonic Distortion at the Output $V_{RMS}$ = 28.3 V, f = 1 kHz, $P_{LOAD}$ = 100 $W_{RMS}$ $h_{FE}$ unmatched  | T <sub>HD</sub>       | _           | 0.8    | _        | %    |
| (Matched pair h <sub>FE</sub> = 50 @ 5 A/5 V) h <sub>FE</sub> matched   |                       | _           | 0.08   | _        |      |
| Current Gain Bandwidth Product $(I_C = 1 \text{ Adc}, V_{CE} = 10 \text{ Vdc}, f_{test} = 1 \text{ MHz})$   | f <sub>T</sub>        | 4           | -      | -        | MHz  |
| Output Capacitance $(V_{CB} = 10 \text{ Vdc}, I_E = 0, f_{test} = 1 \text{ MHz})$   | C <sub>ob</sub>       | -           | _      | 500      | pF   |



NPN MJL21194  $f_{\mathrm{T}}$ , CURRENT GAIN BANDWIDTH PRODUCT (MHz) 8.0 7.0 10 V 6.0 5.0  $V_{CE} = 5 V$ 4.0 3.0 2.0  $T_J = 25^{\circ}C$ 1.0  $f_{test} = 1 \text{ MHz}$ <sub>0</sub> L 10  $I_{\mathbb{C}}$  COLLECTOR CURRENT (AMPS)

Figure 1. Typical Current Gain Bandwidth Product

Figure 2. Typical Current Gain Bandwidth Product

## **TYPICAL CHARACTERISTICS**

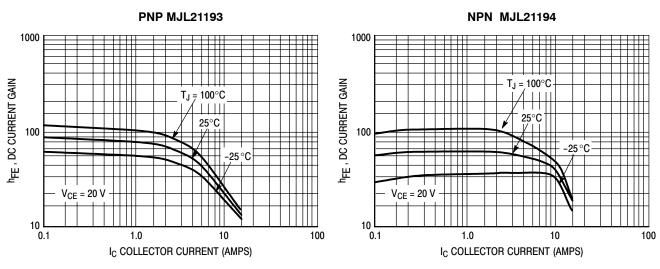


Figure 3. DC Current Gain, V<sub>CE</sub> = 20 V

Figure 4. DC Current Gain, V<sub>CE</sub> = 20 V

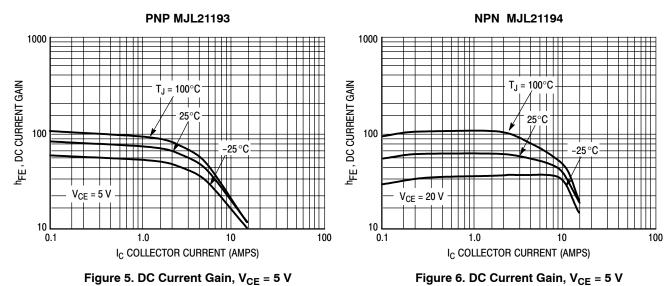
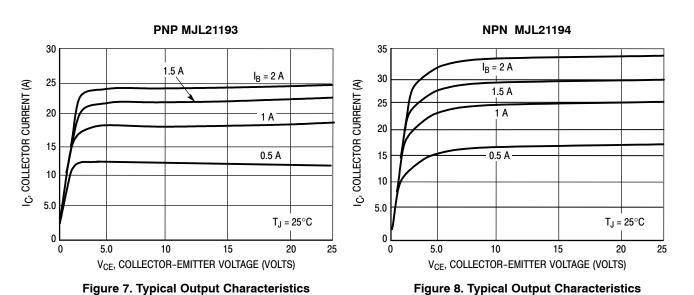


Figure 5. DC Current Gain,  $V_{CE} = 5 \text{ V}$ 



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#### TYPICAL CHARACTERISTICS

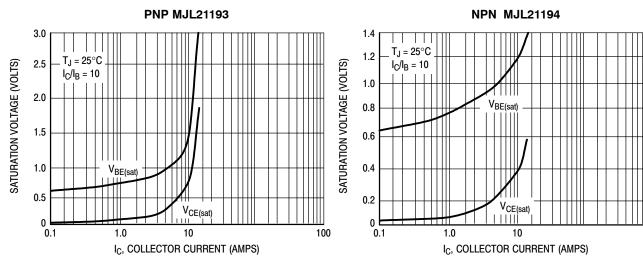


Figure 9. Typical Saturation Voltages

Figure 10. Typical Saturation Voltages

100

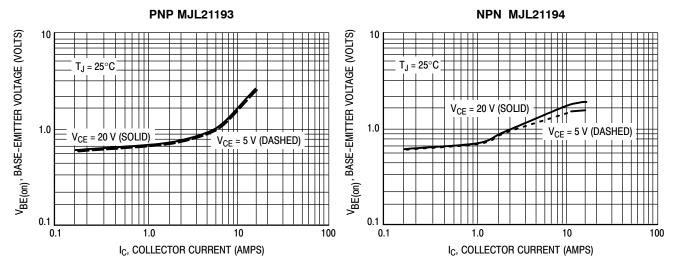


Figure 11. Typical Base-Emitter Voltage

Figure 12. Typical Base-Emitter Voltage

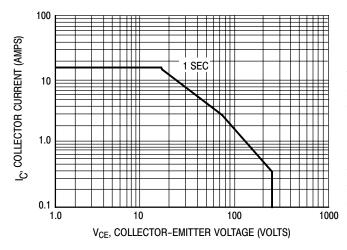


Figure 13. Active Region Safe Operating Area

There are two limitations on the power handling ability of a transistor; average junction temperature and secondary breakdown. Safe operating area curves indicate  $I_C - V_{CE}$  limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 13 is based on  $T_{J(pk)} = 150^{\circ} C$ ;  $T_{C}$  is variable depending on conditions. At high case temperatures, thermal limitations will reduce the power than can be handled to values less than the limitations imposed by second breakdown.

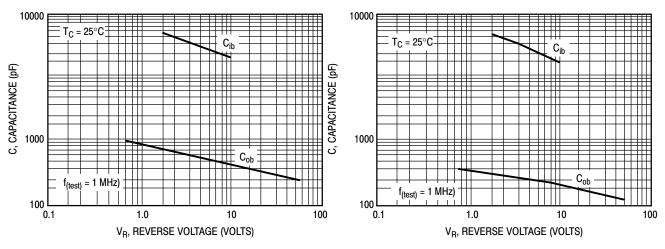


Figure 14. MJL21193 Typical Capacitance

Figure 15. MJL21194 Typical Capacitance

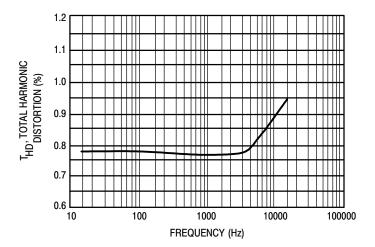


Figure 16. Typical Total Harmonic Distortion

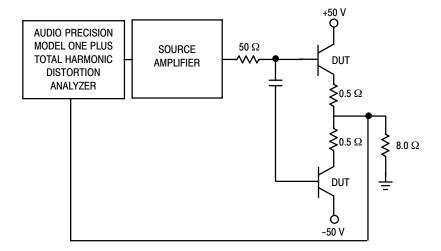
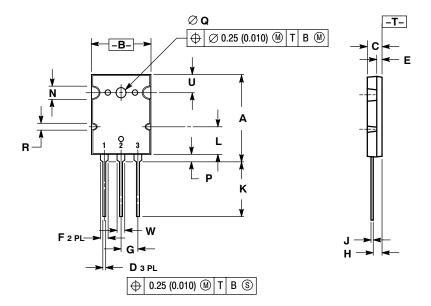


Figure 17. Total Harmonic Distortion Test Circuit

#### PACKAGE DIMENSIONS

TO-3BPL (TO-264) CASE 340G-02 ISSUE J



#### NOTES:

- DIMENSIONING AND TOLERANCING PER
   ANSI V14 5M 1092
- ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.

|     | MILLIN   | IMETERS INCHES |           |       |
|-----|----------|----------------|-----------|-------|
| DIM | MIN      | MAX            | MIN       | MAX   |
| Α   | 28.0     | 29.0           | 1.102     | 1.142 |
| В   | 19.3     | 20.3           | 0.760     | 0.800 |
| С   | 4.7      | 5.3            | 0.185     | 0.209 |
| D   | 0.93     | 1.48           | 0.037     | 0.058 |
| E   | 1.9      | 2.1            | 0.075     | 0.083 |
| F   | 2.2      | 2.4            | 0.087     | 0.102 |
| G   | 5.45 BSC |                | 0.215     | BSC   |
| Н   | 2.6      | 3.0            | 0.102     | 0.118 |
| J   | 0.43     | 0.78           | 0.017     | 0.031 |
| K   | 17.6     | 18.8           | 0.693     | 0.740 |
| L   | 11.2     | 11.2 REF       |           | REF   |
| N   | 4.35     | REF            | 0.172     | REF   |
| Р   | 2.2      | 2.6            | 0.087     | 0.102 |
| Q   | 3.1      | 3.5            | 0.122     | 0.137 |
| R   | 2.25     | REF            | 0.089 REF |       |
| U   | 6.3      | REF            | 0.248 REF |       |
| w   | 28       | 3.2            | 0.110     | 0.125 |

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